

Notice of References Cited

Application/Control No.

09/771,942

Patent Under
Examination

NAKAZAWA ET AL.

Examiner

Michael P Nghiem

Art Unit

2863

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,907,343	05-1999	Takemura et al.	347/108
	B	US-			
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NON-PATENT DOCUMENTS

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